Vishay Siliconix

N-Channel 40 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	40			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.0012			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 7.5 \text{ V}$	0.0017			
Q_g typ. (nC) at $V_{GS} = 7.5 \text{ V}$	63.5			
I _D (A) ^a	201.5			
Configuration	Single			

FEATURES

- TrenchFET® Gen IV standard level MOSFET
- High V_{th} design to avoid noise
- Optimal Q_{qd} / Q_{qs} ratio
- 100 % Rg and UIS tested

 Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

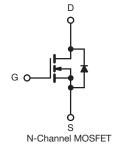


HALOGEN

FREE

APPLICATIONS

- · Synchronous rectification
- High power density DC/DC
- Motor drive control



ORDERING INFORMATION	
Package	PowerPAK SO-8
Lead (Pb)-free and halogen-free, BLR and IOL	SIR5402DP-T1-UE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	40	_ v	
Gate-source voltage		V _{GS}	± 20		
Continuous drain current (V _{GS} = 10 V, T _J = 150 °C)	T _C = 25 °C		201.5		
	T _C = 70 °C		161.2		
	T _A = 25 °C	I _D	49.9 b, c		
	T _A = 70 °C		39.9 b, c	^	
Pulsed drain current (t = 100 µs)		I _{DM}	450	A	
Continuous source-drain diode current	T _C = 25 °C	,	84.1		
	T _A = 25 °C	I _S	5.1 ^{b, c}		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	50		
Single pulse avalanche Energy	L = 0.1 IIII	E _{AS}	125	mJ	
Maximum power dissipation	T _C = 25 °C		92.5		
	T _C = 70 °C		59.2		
	T _A = 25 °C	P _D	5.6 ^{b, c}	W	
	T _A = 70 °C		3.6 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	18	22	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	1.1	1.35]	

Notes

- a. Based on T_C = 25 °C
- b. Surface mounted on 1" x 1" FR4 board
- See solder profile (www.vishav.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components Maximum under steady state conditions is 62.5 °C/W

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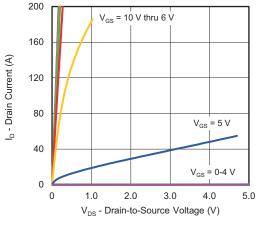
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•				
Drain-source breakdown voltage	V_{DS}	V _{GS} = 0 V, I _D = 1 mA	40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	$I_D = 1 \text{ mA}$	-	34	-	m)//00	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-8.3	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5	-	3.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20$	-	-	± 100	nA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V	-	-	1		
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 75 °C	-	-	20	μA	
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	0.0009	0.0012	Ω	
		$V_{GS} = 7.5 \text{ V}, I_D = 20 \text{ A}$	-	0.0012	0.0017		
Forward transconductance a	9 _{fs}	V _{DS} = 10 V, I _D = 20 A	-	70	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	5325	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	2050	-		
Reverse transfer capacitance	C _{rss}		-	180	-		
otal gate charge	Q _g	V _{DS} = 20 V, V _{GS} = 10 V, I _D = 20 A	-	82	123	nC	
		V _{DS} = 20 V, V _{GS} = 7.5 V, I _D = 20 A	-	63.5	96		
Gate-source charge	Q_{gs}		-	26	-		
Gate-drain charge	Q _{gd}		-	18	-		
Output charge	Q _{oss}	V _{DS} = 20 V, V _{GS} = 0 V		68	-		
Gate resistance	R_{g}	f = 1 MHz	0.5	1.05	1.8	Ω	
Turn-on delay time	t _{d(on)}		-	20	40		
Rise time	t _r	$V_{DD} = 20 \text{ V}, R_{I} = 1 \Omega$	-	15	30		
Turn-off delay time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	35	70		
Fall time	t _f		-	10	20		
Turn-on delay time	t _{d(on)}		-	25	50	ns	
Rise time	t _r	$V_{DD} = 20 \text{ V}, R_{L} = 1 \Omega$	-	18	36	-	
Turn-off delay time	t _{d(off)}	$I_D \cong 20 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$	-	31	62		
Fall time	t _f		-	12	24		
Drain-Source Body Diode Characteristic	s		1			I.	
Continuous source-drain diode current	IS	T _C = 25 °C		-	84.1	^	
Pulse diode forward current (t _p = 100 μs)	I _{SM}		-	-	450	A	
Body diode voltage	V _{SD}	I _S = 5 A	-	0.73	1.1	V	
Body diode reverse recovery time	t _{rr}		-	54	108	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	60	120	nC	
Reverse recovery fall time	t _a	T _J = 25 °C	-	25	-	ns	
Reverse recovery rise time	t _b		-	29	-		

Notes

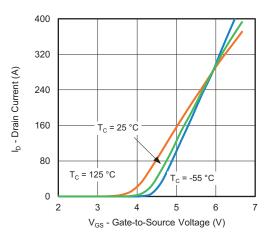
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

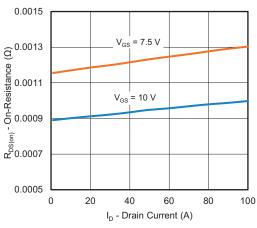




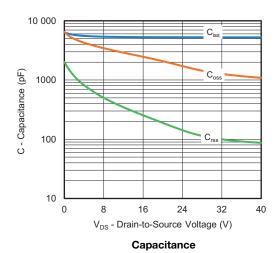
Output Characteristics

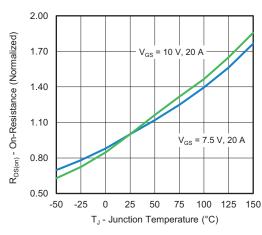


Transfer Characteristics

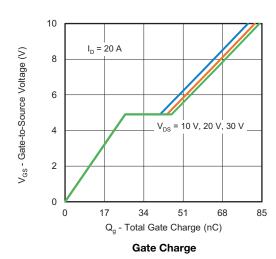


On-Resistance vs. Drain Current

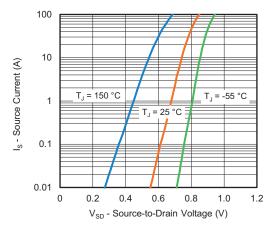




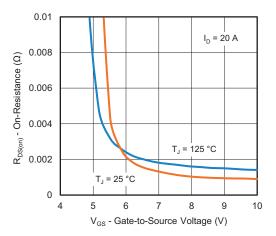
On-Resistance vs. Junction Temperature



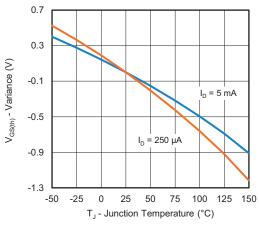




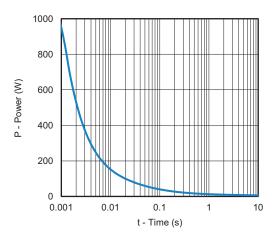
Source-Drain Diode Forward Voltage



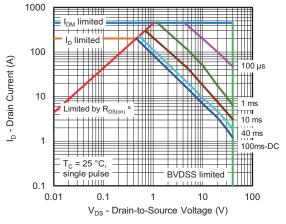
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



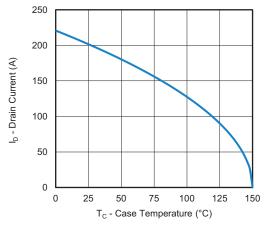
Single Pulse Power, Junction-to-Ambient



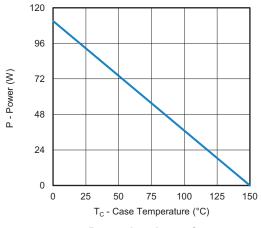
Safe Operating Area, Junction-to-Case

Note

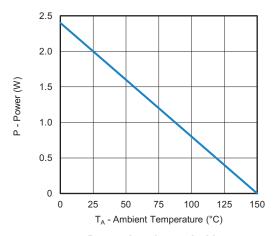
a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified



Current Derating a



Power, Junction-to-Case

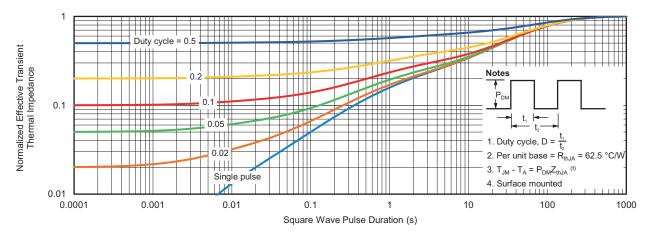


Power, Junction-to-Ambient

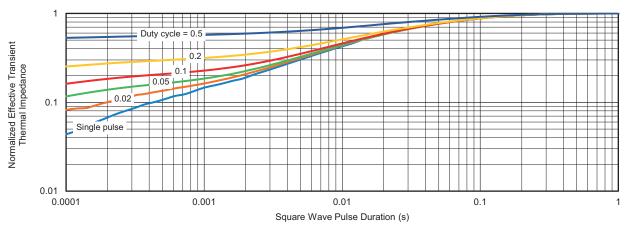
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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